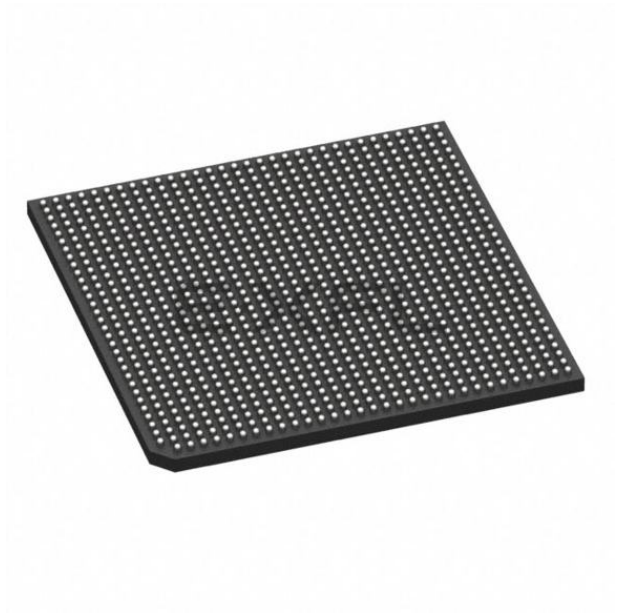

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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	2 Core, 32-Bit
Speed	1.5GHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR2, DDR3
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.5V, 1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	1023-BFBGA, FCBGA
Supplier Device Package	1023-FCBGA (33x33)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8572lpxavnd

Table 11. DDR2 SDRAM Interface DC Electrical Characteristics for GV_{DD}(typ) = 1.8 V (continued)

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Output low current (V_{OUT} = 0.280 V)	I_{OL}	13.4	—	mA	—

Notes:
1. GV_{DD} is expected to be within 50 mV of the DRAM GV_{DD} at all times.
2. $MV_{REF}n$ is expected to be equal to 0.5 × GV_{DD}, and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on $MV_{REF}n$ may not exceed ±2% of the DC value.
3. V_{TT} is not applied directly to the device. It is the supply to that far end signal termination is made and is expected to be equal to $MV_{REF}n$. This rail should track variations in the DC level of $MV_{REF}n$.
4. Output leakage is measured with all outputs disabled, 0 V ≤ V_{OUT} ≤ GV_{DD}.

Table 12 provides the recommended operating conditions for the DDR SDRAM controller of the MPC8572E when interfacing to DDR3 SDRAM.

Table 12. DDR3 SDRAM Interface DC Electrical Characteristics for GV_{DD}(typ) = 1.5 V

Parameter/Condition	Symbol	Min	Typical	Max	Unit
I/O supply voltage	GV_{DD}	1.425	1.575	V	1
I/O reference voltage	$MV_{REF}n$	0.49 × GV_{DD}	0.51 × GV_{DD}	V	2
Input high voltage	V_{IH}	$MV_{REF}n$ + 0.100	GV_{DD}	V	—
Input low voltage	V_{IL}	GND	$MV_{REF}n$ – 0.100	V	—
Output leakage current	I_{OZ}	–50	50	µA	3

Notes:
1. GV_{DD} is expected to be within 50 mV of the DRAM GV_{DD} at all times.
2. $MV_{REF}n$ is expected to be equal to 0.5 × GV_{DD}, and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on $MV_{REF}n$ may not exceed ±1% of the DC value.
3. Output leakage is measured with all outputs disabled, 0 V ≤ V_{OUT} ≤ GV_{DD}.

Table 13 provides the DDR SDRAM controller interface capacitance for DDR2 and DDR3.

Table 13. DDR2 and DDR3 SDRAM Interface Capacitance for GV_{DD}(typ)=1.8 V and 1.5 V

Parameter/Condition	Symbol	Min	Typical	Max	Unit
Input/output capacitance: DQ, DQS, $\overline{DQS}$	C_{IO}	6	8	pF	1, 2
Delta input/output capacitance: DQ, DQS, $\overline{DQS}$	C_{DIO}	—	0.5	pF	1, 2

Note:
1. This parameter is sampled. GV_{DD} = 1.8 V ± 0.090 V (for DDR2), f = 1 MHz, T_A = 25°C, V_{OUT} = GV_{DD}/2, V_{OUT} (peak-to-peak) = 0.2 V.
2. This parameter is sampled. GV_{DD} = 1.5 V ± 0.075 V (for DDR3), f = 1 MHz, T_A = 25°C, V_{OUT} = GV_{DD}/2, V_{OUT} (peak-to-peak) = 0.175 V.

Figure 12 shows the MII transmit AC timing diagram.

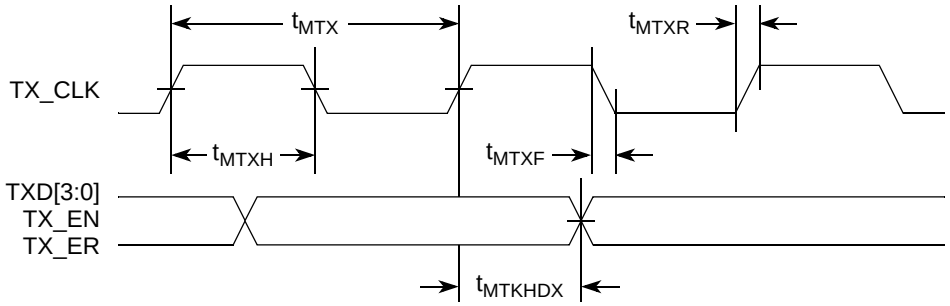

Figure 12. MII Transmit AC Timing Diagram

8.2.3.2 MII Receive AC Timing Specifications

Table 30 provides the MII receive AC timing specifications.

Table 30. MII Receive AC Timing Specifications

At recommended operating conditions with LV_{DD}/TV_{DD} of 2.5/ 3.3 V ± 5%.

Parameter/Condition	Symbol [1]	Min	Typ	Max	Unit
RX_CLK clock period 10 Mbps	t_{MRX}[2]	—	400	—	ns
RX_CLK clock period 100 Mbps	t_{MRX}	—	40	—	ns
RX_CLK duty cycle	t_{MRXH}/t_{MRX}	35	—	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t_{MRDVKH}	10.0	—	—	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t_{MRDXKH}	10.0	—	—	ns
RX_CLK clock rise (20%-80%)	t_{MRXR}[2]	1.0	—	4.0	ns
RX_CLK clock fall time (80%-20%)	t_{MRXF}[2]	1.0	—	4.0	ns

Notes:

1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state) (reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{MRDVKH} symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MRX} clock reference (K) going to the high (H) state or setup time. Also, t_{MRDXKL} symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t_{MRX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{MRX} represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Guaranteed by design.

Figure 13 provides the AC test load for eTSEC.

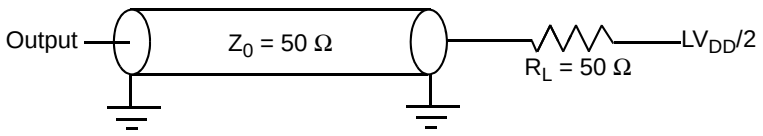

Figure 13. eTSEC AC Test Load

described in Section 21.5, “Connection Recommendations,” as long as such termination does not violate the desired POR configuration requirement on these pins, if applicable.

When operating in SGMII mode, the eTSEC EC_GTX_CLK125 clock is not required for this port. Instead, SerDes reference clock is required on SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$ pins.

8.3.1 DC Requirements for SGMII SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$

The characteristics and DC requirements of the separate SerDes reference clock are described in Section 15, “High-Speed Serial Interfaces (HSSI).”

8.3.2 AC Requirements for SGMII SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$

Table 37 lists the SGMII SerDes reference clock AC requirements. Note that SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$ are not intended to be used with, and should not be clocked by, a spread spectrum clock source.

Table 37. SD2_REF_CLK and $\overline{\text{SD2\_REF\_CLK}}$ AC Requirements

Symbol	Parameter Description	Min	Typical	Max	Units	Notes
t_{REF}	REFCLK cycle time	—	10 (8)	—	ns	1
t_{REFCJ}	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles	—	—	100	ps	—
t_{REFPJ}	Phase jitter. Deviation in edge location with respect to mean edge location	–50	—	50	ps	—

Note:
1. 8 ns applies only when 125 MHz SerDes2 reference clock frequency is selected through cfg_srds_sgmii_refclk during POR.

Table 38. SGMII DC Transmitter Electrical Characteristics (continued)

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Change in V_{OS} between "0" and "1"	ΔV_{OS}	—	—	25	mV	—
Output current on short to GND	I_{SA}, I_{SB}	—	—	40	mA	—

Note:

1. This will not align to DC-coupled SGMII. $XV_{DD\_SRDS2\text{-}Typ}$=1.1 V.
2. $|V_{OD}| = |V_{SD2\_TXn} - V_{\overline{SD2\_TXn}}|$. $|V_{OD}|$ is also referred as output differential peak voltage. $V_{TX\text{-}DIFFp\text{-}p} = 2*|V_{OD}|$.
3. The $|V_{OD}|$ value shown in the table assumes the following transmit equalization setting in the XMITEQ**AB** (for SerDes 2 lanes A & B) or XMITEQ**EF** (for SerDes 2 lanes E & E) bit field of MPC8572E's SerDes 2 Control Register:
   - •The MSbit (bit 0) of the above bit field is set to zero (selecting the full $V_{DD\text{-}DIFF\text{-}p\text{-}p}$ amplitude - power up default);
   - •The LSbits (bit [1:3]) of the above bit field is set based on the equalization setting shown in table.
4. V_{OS} is also referred to as output common mode voltage.
   - 5.The $|V_{OD}|$ value shown in the Typ column is based on the condition of $XV_{DD\_SRDS2\text{-}Typ}$=1.1V, no common mode offset variation (V_{OS} =550mV), SerDes2 transmitter is terminated with 100-Ω differential load between SD2_TX[n] and $\overline{SD2\_TX}$[n].

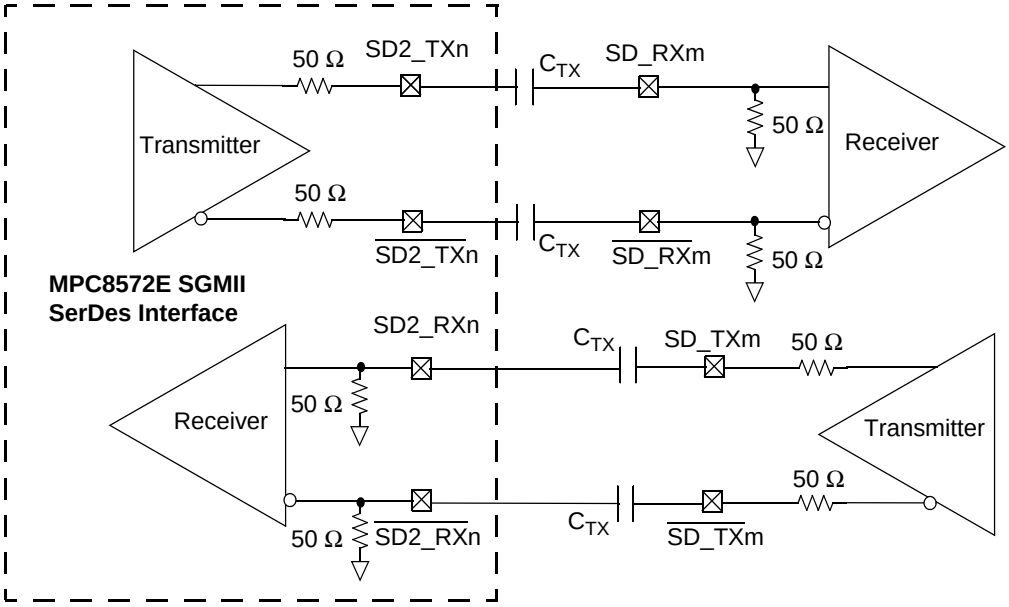

Figure 22. 4-Wire AC-Coupled SGMII Serial Link Connection Example

Table 51. Local Bus General Timing Parameters (BV_{DD} = 1.8 V DC)—PLL Enabled (continued)

At recommended operating conditions with BV_{DD} of 1.8 V ± 5% (continued)

Parameter	Symbol [1]	Min	Max	Unit	Notes
$\overline{\text{LGTA}}$/LUPWAIT input hold from local bus clock	$t_{LBIXKH2}$	1.1	—	ns	3, 4
LALE output negation to high impedance for LAD/LDP (LATCH hold time)	t_{LBOTOT}	1.2	—	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	$t_{LBKHOV1}$	—	3.2	ns	—
Local bus clock to data valid for LAD/LDP	$t_{LBKHOV2}$	—	3.2	ns	3
Local bus clock to address valid for LAD	$t_{LBKHOV3}$	—	3.2	ns	3
Local bus clock to LALE assertion	$t_{LBKHOV4}$	—	3.2	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	$t_{LBKHOX1}$	0.9	—	ns	3
Output hold from local bus clock for LAD/LDP	$t_{LBKHOX2}$	0.9	—	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	$t_{LBKHOZ1}$	—	2.6	ns	5
Local bus clock to output high impedance for LAD/LDP	$t_{LBKHOZ2}$	—	2.6	ns	5

Note:

1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(First two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(First two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, $t_{LBIXKH1}$ symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t_{LBK} clock reference (K) goes high (H), in this case for clock one(1). Also, t_{LBKHOX} symbolizes local bus timing (LB) for the t_{LBK} clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
2. All timings are in reference to LSYNC_IN for PLL enabled and internal local bus clock for PLL bypass mode.
3. All signals are measured from $BV_{DD}/2$ of the rising edge of LSYNC_IN for PLL enabled or internal local bus clock for PLL bypass mode to $0.4 \times BV_{DD}$ of the signal in question for 1.8-V signaling levels.
4. Input timings are measured at the pin.
5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
6. t_{LBOTOT} is a measurement of the minimum time between the negation of LALE and any change in LAD. t_{LBOTOT} is programmed with the LBCR[AHD] parameter.
7. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at $BV_{DD}/2$.
8. Guaranteed by design.

Figure 29 provides the AC test load for the local bus.

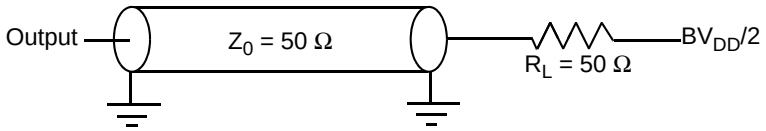

Figure 29. Local Bus AC Test Load

Table 58 provides the DC electrical characteristics for the GPIO interface operating at BV_{DD} = 1.8 V DC.

Table 58. GPIO DC Electrical Characteristics (1.8 V DC)

Parameter	Symbol	Min	Max	Unit
Supply voltage 1.8V	BV_{DD}	1.71	1.89	V
High-level input voltage	V_{IH}	0.65 x BV_{DD}	BV_{DD} + 0.3	V
Low-level input voltage	V_{IL}	–0.3	0.35 x BV_{DD}	V
Input current (BV_{IN} [1] = 0 V or BV_{IN} = BV_{DD})	I_{IN}	TBD	TBD	μA
High-level output voltage (I_{OH} = –100 μA)	V_{OH}	BV_{DD} – 0.2	—	V
High-level output voltage (I_{OH} = –2 mA)	V_{OH}	BV_{DD} – 0.45	—	V
Low-level output voltage (I_{OL} = 100 μA)	V_{OL}	—	0.2	V
Low-level output voltage (I_{OL} = 2 mA)	V_{OL}	—	0.45	V

Note:
1. The symbol BV_{IN}, in this case, represents the BV_{IN} symbol referenced in Table 1.

14.2 GPIO AC Electrical Specifications

Table 59 provides the GPIO input and output AC timing specifications.

Table 59. GPIO Input AC Timing Specifications[1]

Parameter	Symbol	Typ	Unit	Notes
GPIO inputs—minimum pulse width	t_{PIWID}	20	ns	2

Notes:
1. Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of SYSCLK. Timings are measured at the pin.
2. GPIO inputs and outputs are asynchronous to any visible clock. GPIO outputs should be synchronized before use by any external synchronous logic. GPIO inputs are required to be valid for at least t_{PIWID} ns to ensure proper operation.

Figure 42 provides the AC test load for the GPIO.

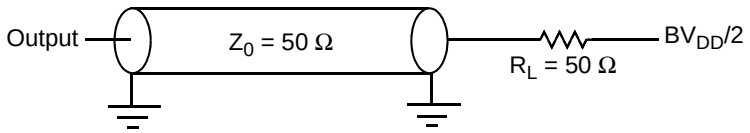

Figure 42. GPIO AC Test Load

Figure 48 shows the SerDes reference clock connection reference circuits for HCSL type clock driver. It assumes that the DC levels of the clock driver chip is compatible with MPC8572E SerDes reference clock input's DC requirement.

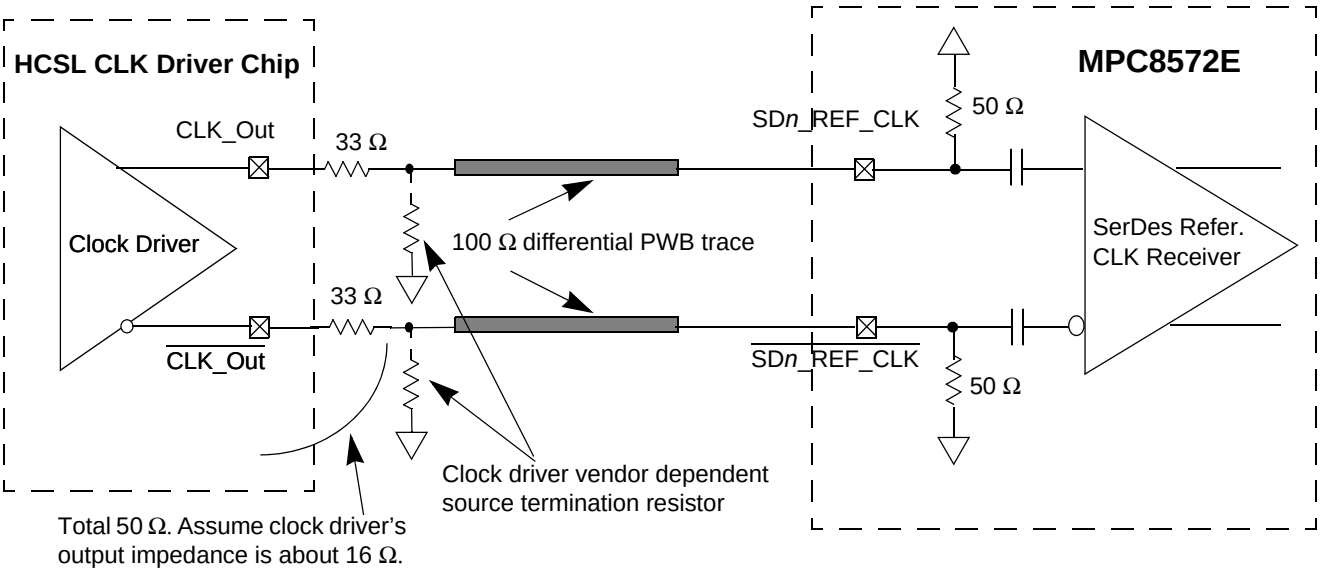

Figure 48. DC-Coupled Differential Connection with HCSL Clock Driver (Reference Only)

- Section 17, “Serial RapidIO”

Note that external AC Coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in specification of each protocol section.

16 PCI Express

This section describes the DC and AC electrical specifications for the PCI Express bus of the MPC8572E.

16.1 DC Requirements for PCI Express SD1_REF_CLK and SD1_REF_CLK

For more information, see Section 15.2, “SerDes Reference Clocks.”

16.2 AC Requirements for PCI Express SerDes Reference Clocks

Table 61 lists AC requirements.

Table 61. SD1_REF_CLK and $\overline{\text{SD1\_REF\_CLK}}$ AC Requirements

Symbol	Parameter Description	Min	Typical	Max	Units	Notes
t_{REF}	REFCLK cycle time	—	10	—	ns	1
t_{REFCJ}	REFCLK cycle-to-cycle jitter. Difference in the period of any two adjacent REFCLK cycles	—	—	100	ps	—
t_{REFPJ}	Phase jitter. Deviation in edge location with respect to mean edge location	–50	—	50	ps	—

Notes:
1. Typical cycle time is based on PCI Express Card Electromechanical Specification Revision 1.0a.

16.3 Clocking Dependencies

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a +/– 300 ppm tolerance.

16.4 Physical Layer Specifications

The following is a summary of the specifications for the physical layer of PCI Express on this device. For further details as well as the specifications of the transport and data link layer, Use the PCI Express Base Specification. REV. 1.0a document.

16.4.1 Differential Transmitter (TX) Output

Table 62 defines the specifications for the differential output at all transmitters (TXs). The parameters are specified at the component pins.

16.5 Receiver Compliance Eye Diagrams

The RX eye diagram in Figure 56 is specified using the passive compliance/test measurement load (see Figure 57) in place of any real PCI Express RX component.

Note: In general, the minimum Receiver eye diagram measured with the compliance/test measurement load (see Figure 57) is larger than the minimum Receiver eye diagram measured over a range of systems at the input Receiver of any real PCI Express component. The degraded eye diagram at the input Receiver is due to traces internal to the package as well as silicon parasitic characteristics which cause the real PCI Express component to vary in impedance from the compliance/test measurement load. The input Receiver eye diagram is implementation specific and is not specified. RX component designer should provide additional margin to adequately compensate for the degraded minimum Receiver eye diagram (shown in Figure 56) expected at the input Receiver based on some adequate combination of system simulations and the Return Loss measured looking into the RX package and silicon. The RX eye diagram must be aligned in time using the jitter median to locate the center of the eye diagram.

The eye diagram must be valid for any 250 consecutive UIs.

A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. The eye diagram is created using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI.

NOTE

The reference impedance for return loss measurements is 50. to ground for both the D+ and D- line (that is, as measured by a Vector Network Analyzer with 50. probes—see Figure 57). Note that the series capacitors, CTX, are optional for the return loss measurement.

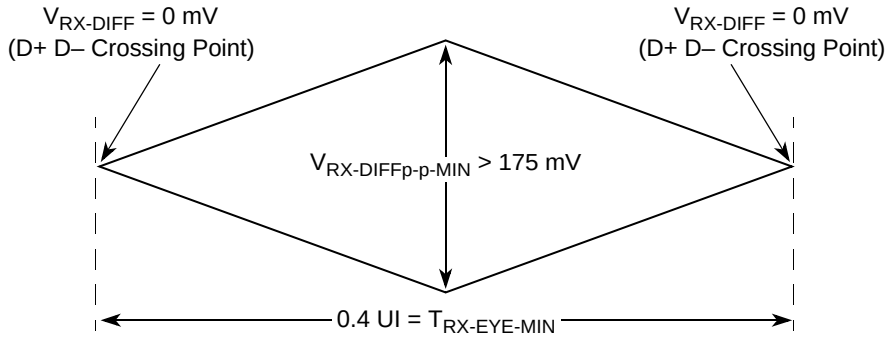

Figure 56. Minimum Receiver Eye Timing and Voltage Compliance Specification

Table 66. Short Run Transmitter AC Timing Specifications—2.5 GBaud (continued)

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Multiple Output skew	S_{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	400	400	ps	+/- 100 ppm

Table 67. Short Run Transmitter AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output Voltage,	V_O	–0.40	2.30	Volts	Voltage relative to COMMON of either signal comprising a differential pair
Differential Output Voltage	V_{DIFFPP}	500	1000	mV p-p	—
Deterministic Jitter	J_D	—	0.17	UI p-p	—
Total Jitter	J_T	—	0.35	UI p-p	—
Multiple output skew	S_{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	320	320	ps	+/– 100 ppm

Table 68. Long Run Transmitter AC Timing Specifications—1.25 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output Voltage,	V_O	–0.40	2.30	Volts	Voltage relative to COMMON of either signal comprising a differential pair
Differential Output Voltage	V_{DIFFPP}	800	1600	mV p-p	—
Deterministic Jitter	J_D	—	0.17	UI p-p	—
Total Jitter	J_T	—	0.35	UI p-p	—
Multiple output skew	S_{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	800	800	ps	+/- 100 ppm

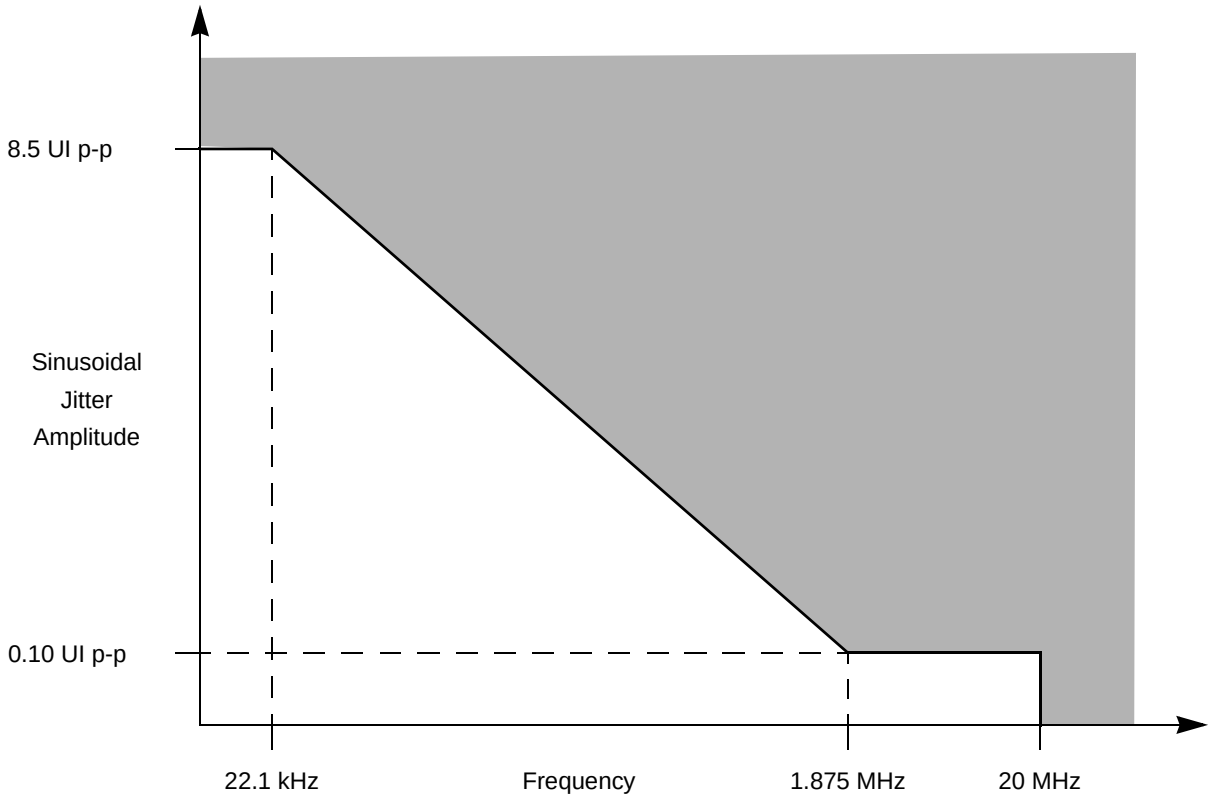

Figure 59. Single Frequency Sinusoidal Jitter Limits

17.7 Receiver Eye Diagrams

For each baud rate at which an LP-Serial receiver is specified to operate, the receiver shall meet the corresponding Bit Error Rate specification (Table 72, Table 73, and Table 74) when the eye pattern of the receiver test signal (exclusive of sinusoidal jitter) falls entirely within the unshaded portion of the Receiver Input Compliance Mask shown in Figure 60 with the parameters specified in Table 75. The eye pattern of the receiver test signal is measured at the input pins of the receiving device with the device replaced with a 100-Ω +/– 5% differential resistive load.

18.1 Package Parameters for the MPC8572E FC-PBGA

The package parameters are as provided in the following list. The package type is 33 mm × 33 mm, 1023 flip chip plastic ball grid array (FC-PBGA).

Package outline	33 mm × 33 mm
Interconnects	1023
Ball Pitch	1 mm
Ball Diameter (Typical)	0.6 mm
Solder Balls	63% Sn
	37% Pb
Solder Balls (Lead-Free)	96.5% Sn
	3.5% Ag

18.2 Mechanical Dimensions of the MPC8572E FC-PBGA

Figure 61 shows the mechanical dimensions of the MPC8572E FC-PBGA package with full lid.

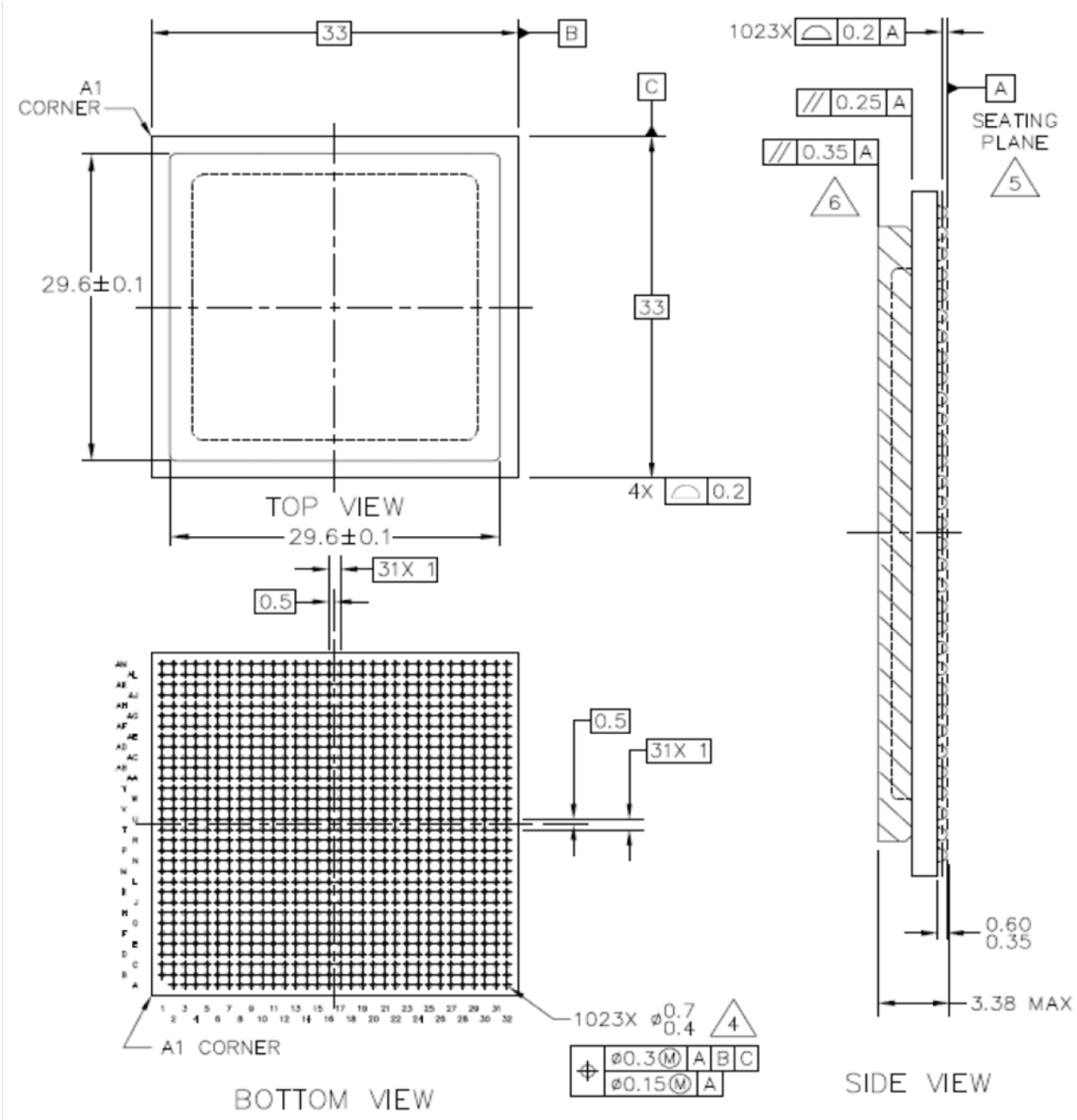

Figure 61. Mechanical Dimensions of the MPC8572E FC-PBGA with Full Lid

NOTES:

1. All dimensions are in millimeters.
2. Dimensions and tolerances per ASME Y14.5M-1994.
3. All dimensions are symmetric across the package center lines unless dimensioned otherwise.
4. Maximum solder ball diameter measured parallel to datum A.

5. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
6. Parallelism measurement shall exclude any effect of mark on top surface of package.

18.3 Pinout Listings

Table 76 provides the pin-out listing for the MPC8572E 1023 FC-PBGA package.

Table 76. MPC8572E Pinout Listing

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
DDR SDRAM Memory Interface 1					
D1_MDQ[0:63]	Data	D15, A14, B12, D12, A15, B15, B13, C13, C11, D11, D9, A8, A12, A11, A9, B9, F11, G12, K11, K12, E10, E9, J11, J10, G8, H10, L10, M11, F10, G9, K9, K8, AC6, AC7, AG8, AH9, AB6, AB8, AE9, AF9, AL8, AM8, AM10, AK11, AH8, AK8, AJ10, AK10, AL12, AJ12, AL14, AK14, AL11, AM11, AK13, AM14, AM15, AJ16, AL18, AM18, AJ15, AL15, AK17, AM17	I/O	GV_{DD}	—
D1_MECC[0:7]	Error Correcting Code	M10, M7, R8, T11, L12, L11, P9, R10	I/O	GV_{DD}	—
$\overline{\text{D1\_MAPAR\_ERR}}$	Address Parity Error	P6	I	GV_{DD}	—
D1_MAPAR_OUT	Address Parity Out	W6	O	GV_{DD}	—
D1_MDM[0:8]	Data Mask	C14, A10, G11, H9, AD7, AJ9, AM12, AK16, N11	O	GV_{DD}	—
D1_MDQS[0:8]	Data Strobe	A13, C10, H12, J7, AE8, AM9, AM13, AL17, N9	I/O	GV_{DD}	—
$\overline{\text{D1\_MDQS}}$[0:8]	Data Strobe	D14, B10, H13, J8, AD8, AL9, AJ13, AM16, P10	I/O	GV_{DD}	—
D1_MA[0:15]	Address	Y7, W8, U6, W9, U7, V8, Y11, V10, T6, V11, AA10, U9, U10, AD11, T8, P7	O	GV_{DD}	—
D1_MBA[0:2]	Bank Select	AA7, AA8, R7	O	GV_{DD}	—
$\overline{\text{D1\_MWE}}$	Write Enable	AC12	O	GV_{DD}	—

Table 76. MPC8572E Pinout Listing (continued)

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
TSEC1_RX_DV/FIFO1_RX_DV/FIFO1_RXC[0]	Receive Data Valid	AL24	I	LV_{DD}	1
TSEC1_RX_ER/FIFO1_RX_ER/FIFO1_RXC[1]	Receive Data Error	AM29	I	LV_{DD}	1
TSEC1_TX_CLK/FIFO1_TX_CLK	Transmit Clock In	AB20	I	LV_{DD}	1
TSEC1_TX_EN/FIFO1_TX_EN/FIFO1_TXC[0]	Transmit Enable	AJ24	O	LV_{DD}	1, 22
TSEC1_TX_ER/FIFO1_TX_ERR/FIFO1_TXC[1]	Transmit Error	AK25	O	LV_{DD}	1, 5, 9
Three-Speed Ethernet Controller 2					
TSEC2_RXD[7:0]/FIFO2_RXD[7:0]/FIFO1_RXD[15:8]	Receive Data	AG22, AH20, AL22, AG20, AK21, AK22, AJ21, AK20	I	LV_{DD}	1
TSEC2_TXD[7:0]/FIFO2_TXD[7:0]/FIFO1_TXD[15:8]	Transmit Data	AH21, AF20, AC17, AF21, AD18, AF22, AE20, AB18	O	LV_{DD}	1, 5, 9, 24
TSEC2_COL/FIFO2_TX_FC	Collision Detect/Flow Control	AE19	I	LV_{DD}	1
TSEC2_CRS/FIFO2_RX_FC	Carrier Sense/Flow Control	AJ20	I/O	LV_{DD}	1, 16
TSEC2_GTX_CLK	Transmit Clock Out	AE18	O	LV_{DD}	—
TSEC2_RX_CLK/FIFO2_RX_CLK	Receive Clock	AL23	I	LV_{DD}	1
TSEC2_RX_DV/FIFO2_RX_DV/FIFO1_RXC[2]	Receive Data Valid	AJ22	I	LV_{DD}	1
TSEC2_RX_ER/FIFO2_RX_ER	Receive Data Error	AD19	I	LV_{DD}	1
TSEC2_TX_CLK/FIFO2_TX_CLK	Transmit Clock In	AC19	I	LV_{DD}	1
TSEC2_TX_EN/FIFO2_TX_EN/FIFO1_TXC[2]	Transmit Enable	AB19	O	LV_{DD}	1, 22
TSEC2_TX_ER/FIFO2_TX_ERR	Transmit Error	AB17	O	LV_{DD}	1, 5, 9
Three-Speed Ethernet Controller 3					
TSEC3_TXD[3:0]/FEC_TXD[3:0]/FIFO3_TXD[3:0]	Transmit Data	AG18, AG17, AH17, AH19	O	TV_{DD}	1, 5, 9
TSEC3_RXD[3:0]/FEC_RXD[3:0]/FIFO3_RXD[3:0]	Receive Data	AG16, AK19, AD16, AJ19	I	TV_{DD}	1

Table 76. MPC8572E Pinout Listing (continued)

Signal	Signal Name	Package Pin Number	Pin Type	Power Supply	Notes
Power and Ground Signals					
GND	Ground	A18, A25, A29, C3, C6, C9, C12, C15, C20, C22, E5, E8, E11, E14, F3, G7, G10, G13, G16, H5, H21, J3, J9, J12, J18, K7, L5, L13, L15, L16, L21, M3, M9, M12, M14, M16, M18, N7, N13, N15, N17, N19, N21, N23, P5, P12, P14, P16, P20, P22, R3, R9, R11, R13, R15, R17, R19, R21, R23, R26, T7, T12, T14, T16, T18, T20, T22, T30, U5, U11, U13, U15, U16, U17, U19, U21, U23, U25, V3, V9, V12, V14, V16, V18, V20, V22, W7, W11, W13, W15, W17, W19, W21, W27, W32, Y5, Y12, Y14, Y16, Y18, Y20, AA3, AA9, AA13, AA15, AA17, AA19, AA21, AA30, AB7, AB26, AC5, AC11, AC13, AD3, AD9, AD14, AD17, AD22, AE7, AE13, AF5, AF11, AG3, AG9, AG15, AG19, AH7, AH13, AH22, AJ5, AJ11, AJ17, AK3, AK9, AK15, AK24, AL7, AL13, AL19, AL26	—	—	—
XGND_SRDS1	SerDes Transceiver Pad GND (xpadvss)	C23, C27, D23, D25, E23, E26, F23, F24, G23, G27, H23, H25, J23, J26, K23, K24, L27, M25	—	—	—
XGND_SRDS2	SerDes Transceiver Pad GND (xpadvss)	AD23, AD25, AE23, AE27, AF23, AF24, AG23, AG26, AH23, AH25, AJ27	—	—	—

19 Clocking

This section describes the PLL configuration of the MPC8572E. Note that the platform clock is identical to the core complex bus (CCB) clock.

19.1 Clock Ranges

Table 77 provides the clocking specifications for both processor cores.

Table 77. MPC8572E Processor Core Clocking Specifications

Characteristic	Maximum Processor Core Frequency								Unit	Notes
	1067 MHz		1200 MHz		1333 MHz		1500 MHz			
	Min	Max	Min	Max	Min	Max	Min	Max		
e500 core processor frequency	800	1067	800	1200	800	1333	800	1500	MHz	1, 2
CCB frequency	400	533	400	533	400	533	400	600	MHz	
DDR Data Rate	400	667	400	667	400	667	400	800	MHz	

Notes:
1. **Caution:** The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies. Refer to Section 19.2, “CCB/SYSCLK PLL Ratio,” Section 19.3, “e500 Core PLL Ratio,” and Section 19.4, “DDR/DDRCLK PLL Ratio,” for ratio settings.
2. The processor core frequency speed bins listed also reflect the maximum platform (CCB) and DDR data rate frequency supported by production test. Running CCB and/or DDR data rate higher than the limit shown above, although logically possible via valid clock ratio setting in some condition, is not supported.

The DDR memory controller can run in either synchronous or asynchronous mode. When running in synchronous mode, the memory bus is clocked relative to the platform clock frequency. When running in asynchronous mode, the memory bus is clocked with its own dedicated PLL with clock provided on DDRCLK input pin. Table 78 provides the clocking specifications for the memory bus.

Table 79. CCB Clock Ratio

Binary Value of LA[29:31] Signals	CCB:SYSCLK Ratio
000	4:1
001	5:1
010	6:1
011	8:1
100	10:1
101	12:1
110	Reserved
111	Reserved

19.3 e500 Core PLL Ratio

The clock speed for each e500 core can be configured differently, determined by the values of various signals at power up.

Table 80 describes the clock ratio between e500 Core0 and the e500 core complex bus (CCB). This ratio is determined by the binary value of LBCTL, LALE and LGPL2/$\overline{\text{LOE}}$/$\overline{\text{LFRE}}$ at power up, as shown in Table 80.

Table 80. e500 Core0 to CCB Clock Ratio

Binary Value of LBCTL, LALE, LGPL2/LOE/LFRE Signals	e500 Core0:CCB Clock Ratio	Binary Value of LBCTL, LALE, LGPL2/LOE/LFRE Signals	e500 Core0:CCB Clock Ratio
000	Reserved	100	2:1
001	Reserved	101	5:2 (2.5:1)
010	Reserved	110	3:1
011	3:2 (1.5:1)	111	7:2 (3.5:1)

Figure 66. JTAG Interface Connection

21.10 Guidelines for High-Speed Interface Termination

21.10.1 SerDes 1 Interface Entirely Unused

If the high-speed SerDes 1 interface is not used at all, the unused pin should be terminated as described in this section.

The following pins must be left unconnected (float):

- SD1_TX[7:0]
- $\overline{\text{SD1\_TX}}$[7:0]
- Reserved pins C24, C25, H26, H27

The following pins must be connected to XGND_SRDS1:

- SD1_RX[7:0]
- $\overline{\text{SD1\_RX}}$[7:0]
- SD1_REF_CLK
- $\overline{\text{SD1\_REF\_CLK}}$

Pins K32 and C29 must be tied to XV_{DD}_SRDS1. Pins K31 and C30 must be tied to XGND_SRDS1 through a 300-Ω resistor.

The POR configuration pin cfg_srds1_en on TSEC2_TXD[5] can be used to power down SerDes 1 block for power saving. Note that both SVDD_SRDS1 and XVDD_SRDS1 must remain powered.

21.10.2 SerDes 1 Interface Partly Unused

If only part of the high speed SerDes 1 interface pins are used, the remaining high-speed serial I/O pins should be terminated as described in this section.

The following pins must be left unconnected (float) if not used:

- SD1_TX[7:0]
- $\overline{\text{SD1\_TX}}$[7:0]
- Reserved pins: C24, C25, H26, H27

The following pins must be connected to XGND_SRDS1 if not used:

- SD1_RX[7:0]
- $\overline{\text{SD1\_RX}}$[7:0]

Pins K32 and C29 must be tied to XV_{DD}_SRDS1. Pins K31 and C30 must be tied to XGND_SRDS1 through a 300-Ω resistor.

Table 87. Part Numbering Nomenclature—Rev 2.1

MPC	*nnnn*	*e*	*t*	*l*	*pp*	*ffm*	*r*

Product Code[1]	Part Identifier	Security Engine	Temperature	Power	Package Sphere Type[2]	Processor Frequency/ DDR Data Rate[3]	Silicon Revision
MPC PPC	8572	E = Included	Blank = 0 to 105°C C = –40 to 105°C	Blank = Standard L = Low	PX = Leaded, FC-PBGA VT = Pb-free, FC-PBGA	AVN = 150- MHz processor; 800 MT/s DDR data rate AUL = 1333-MHz processor; 667 MT/s DDR data rate ATL = 1200-MHz processor; 667 MT/s DDR data rate ARL = 1067-MHz processor; 667 MT/s DDR data rate	D= Ver. 2.1 (SVR = 0x80E8_0021) SEC included
		Blank = Not included					D= Ver. 2.1 (SVR = 0x80E0_0021) SEC not included

Notes:

1 MPC stands for “Qualified.”
PPC stands for “Prototype”

2 See Section 18, “Package Description,” for more information on the available package types.

3 Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by part number specifications may support other maximum core frequencies.

Table 88. Part Numbering Nomenclature—Rev 1.1.1

MPC	*nnnn*	*e*	*t*	*pp*	*ffm*	*r*

Product Code[1]	Part Identifier	Security Engine	Temperature	Package Sphere Type[2]	Processor Frequency/ DDR Data Rate[3]	Silicon Revision
MPC PPC	8572	E = Included	Blank=0 to 105°C C= –40 to 105°C	PX = Leaded, FC-PBGA VT = Pb-free, FC-PBGA	AVN = 1500-MHz processor; 800 MT/s DDR data rate AUL = 1333-MHz process or; 667 MT/s DDR datarate ATL = 1200-MHz processor; 667 MT/s DDR data rate ARL = 1067-MHz processor; 667 MT/s DDR data rate	B = Ver. 1.1.1 (SVR = 0x80E8_0011) SEC included
		Blank = Not included				B = Ver. 1.1.1 (SVR = 0x80E0_0011) SEC not included

Notes:

1 MPC stands for “Qualified.”
PPC stands for “Prototype”

2 See Section 18, “Package Description,” for more information on the available package types.